TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7PA34FU

Dual Non-Invert Buffer with 3.6 V Tolerant Input and Output

Features

- Operating voltage range: VCC = 1.8~3.6 V
- High-speed operation: $t_{pd} = 3.5 \text{ ns (max)}$ at $V_{CC} = 3.0 \sim 3.6 \text{ V}$

$$t_{pd} = 4.2 \text{ ns (max)}$$
 at $V_{CC} = 2.3 \sim 2.7 \text{ V}$

$$t_{pd} = 8.4 \text{ ns (max)}$$
 at $V_{CC} = 1.8 \text{ V}$

• High-level output current:

$$I_{OH}/I_{OL}$$
 = ± 24 mA (min) at V_{CC} = 3.0 V

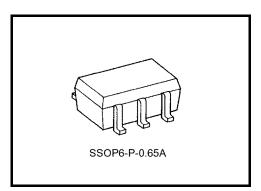
$$I_{OH}/I_{OL} = \pm 18 \text{ mA (min)}$$
 at $V_{CC} = 2.3 \text{ V}$

$$I_{OH}/I_{OL}$$
 = ±6 mA (min) at V_{CC} = 1.8 V

- High latch-up immunity: ±300 mA
- High ESD: Higher than or equal to ± 200 V (JEITA)

Higher than or equal to ±2000 V (MIL)

• 3.6-V tolerant function and power-down protection provided on all inputs and outputs

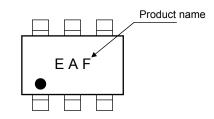


Weight: 0.0068 g (typ.)

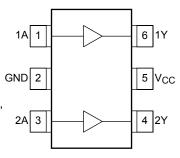
Absolute Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Value	Unit
Power supply voltage	V _{CC}	-0.5~4.6	V
DC input voltage	V _{IN}	-0.5~4.6	V
		-0.5~4.6 (Note 1)	
DC output voltage	V _{OUT}	-0.5~V _{CC} + 0.5 (Note 2)	V
Input diode current	I _{IK}	-50	mA
Output diode current	lok	±50 (Note 3)	mA
DC output current	lout	+50	mA
Power dissipation	PD	200	mW
DC V _{CC} /ground current	Icc	±100	mA
Storage temperature	T _{stg}	-65~150	°C

Marking



Pin Assignment (top view)



Note:

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating

temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: $V_{CC} = 0 V$

Note 2: High or Low state. The I_{OUT} absolute maximum rating must be adhered to.

Note 3: Vout < GND, Vout > Vcc

Truth Table

А	Y
L	L
Н	Н

IEC Logic Symbol



Operating Ranges

Characteristics	Symbol	Value	Unit
Power supply voltage	V _{CC}	1.8~3.6	V
Power supply voltage	VCC.	1.2~3.6 (Note 4)	V
Input voltage	V _{IN}	-0.3~3.6	V
Output voltage	Vour	0~3.6 (Note 5)	V
Output voltage	V _{OUT}	0~V _{CC} (Note 6)	V
		±24 (Note 7)	
Output Current	I _{OH} /I _{OL}	±18 (Note 8)	mA
		±6 (Note 9)	
Operating temperature	T _{opr}	-40~85	°C
Input rise and fall time	d _t /d _v	0~10 (Note 10)	ns/V

Note 4: Data retention only

Note 5: $V_{CC} = 0 V$

Note 6: High or Low state

Note 7: $V_{CC} = 3.0 \sim 3.6 \text{ V}$

Note 8: $V_{CC} = 2.3 \sim 2.7 \text{ V}$

Note 9: $V_{CC} = 1.8 \text{ V}$

Note 10: $V_{IN} = 0.8 \sim 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$

DC Electrical Characteristics (Ta = $-40\sim85^{\circ}$ C, 2.7 V < V_{CC} \leq 3.6 V)

Characteristics	Symbol	Test Condition			Min	Max	Unit	
Characteristics	Symbol	1631	Condition	V _{CC} (V)	IVIIII	IVIAX	Offic	
High-Level Input Voltage	V_{IH}		_	2.7~3.6	2.0	_	V	
Low-Level Input Voltage	V _{IL}		_	2.7~3.6		0.8	V	
			I _{OH} = -100 μA	2.7~3.6	V _{CC} - 0.2	ı		
High-Level Output Voltage	V _{OH}	VIIN — VIII	$I_{OH} = -12 \text{ mA}$	2.7	2.2		V	
			$I_{OH} = -18 \text{ mA}$	3.0	2.4			
			$I_{OH} = -24 \text{ mA}$	3.0	2.2			
			$I_{OL} = 100 \mu A$	2.7~3.6		0.2		
Low-Level Output Voltage	V _{OL}	Maria Mar	$V_{IN} = V_{IL}$	I _{OL} = 12 mA	2.7		0.4	v
Low-Level Output Voltage	VOL	AIM — AIT	$I_{OL} = 18 \text{ mA}$	3.0	_	0.4	V	
			I _{OL} = 24 mA	3.0	_	0.55		
Input Leakage Current	I _{IN}	V _{IN} = 0~3.6 V	V _{IN} = 0~3.6 V		_	±5.0	μА	
Power-off Leakage Current	loff	V _{IN} , V _{OUT} = 0~3.6 V		0	_	10.0	μА	
Outroped County County	loo	V _{IN} = V _{CC} or GND		2.7~3.6	_	20.0		
Quiescent Supply Current	lcc	V _{CC} ≤ (V _{IN} , V _{OI}	_{UT}) ≦ 3.6 V	2.7~3.6	_	±20.0	μΑ	
Increase in I _{CC} per Input	Δlcc	$V_{IH} = V_{CC} - 0.6$	V	2.7~3.6	_	750		

DC Characteristics (Ta = $-40 \sim 85$ °C, 2.3 V \leq V_{CC} \leq 2.7 V)

Characteristics	Symbol	Те	Test Condition		Min	Max	Unit		
High-Level Input Voltage	V_{IH}		_	2.3~2.7	1.6	_	V		
Low-Level Input Voltage	V _{IL}		_	2.3~2.7	_	0.7	V		
			I _{OH} = -100 μA	2.3~2.7	V _{CC} - 0.2	_			
High-Level Output Voltage	V _{OH}	$V_{IN} = V_{IH}$	I _{OH} = -6 mA	2.3	2.0	_	V		
					I _{OH} = -12 mA	2.3	1.8	_	
			I _{OH} = -18 mA	2.3	1.7	_			
			I _{OL} = 100 μA	2.3~2.7	_	0.2	V		
Low-Level Output Voltage	V _{OL}	$V_{IN} = V_{IL} \\$	I _{OL} = 12 mA	2.3	_	0.4	V		
			I _{OL} = 18 mA	2.3	_	0.6			
Input Leakage Current	I _{IN}	V _{IN} = 0~3.6 V	V _{IN} = 0~3.6 V		_	±5.0	μА		
Power-off Leakage Current	l _{OFF}	V _{IN} , V _{OUT} = 0~3.6 V		0		10.0	μА		
Ovice cont Comply Compat	laa	$V_{IN} = V_{CC}$ or Q	V _{IN} = V _{CC} or GND		_	20.0	^		
Quiescent Supply Current	Icc	$V_{CC} \le (V_{IN}, V_{CC})$	OUT) ≦ 3.6 V	2.3~2.7		±20.0	μА		

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DC Characteristics (Ta = $-40\sim85^{\circ}$ C, 1.8 V \leq V_{CC} < 2.3 V)

Characteristics	Symbol				Min	Max	Unit
				V _{CC} (V)			
High-Level Input Voltage	V _{IH}	-	_		$\begin{array}{c} 0.7 \times \\ V_{CC} \end{array}$	_	V
Low-Level Input Voltage	V _{IL}		_		l	0.2 × V _{CC}	•
High-Level Output Voltage	V _{OH}	V _{IN} = V _{IH}	I _{OH} = -100 μA	1.8	V _{CC} - 0.2		>
			$I_{OH} = -6 \text{ mA}$	1.8	1.4	_	
Low Lovel Output Voltage	.,		$I_{OL} = 100 \mu A$	1.8	_	0.2	V
Low-Level Output Voltage	V _{OL}	$V_{IN} = V_{IL}$	I _{OL} = 6 mA	1.8	_	0.3	V
Input Leakage Current	I _{IN}	V _{IN} = 0~3.6 V	V _{IN} = 0~3.6 V		_	±5.0	μА
Power-off Leakage Current	l _{OFF}	V _{IN} , V _{OUT} = 0~3.6 V		0	_	10.0	μА
Quiescent Supply Current		V _{IN} = V _{CC} or GND		1.8	_	20.0	μА
Quiescent Supply Current	Icc	V _{CC} ≤ (V _{IN} , V _{OUT}	-) ≦ 3.6 V	1.8	_	±20.0	μΑ

AC Electrical Characteristics (Ta = $-40 \sim 85^{\circ}$ C, input $t_r = t_f = 2.0$ ns, $C_L = 30$ pF, $R_L = 500$ Ω)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
	4		1.8	1.0	8.4	
ropagation delay time		(Figure 1 and 2)	2.5 ± 0.2	0.8	4.2	ns
	^t pHL		3.3 ± 0.3	0.6	3.5	

For C_L = 50 pF, add approximately 300 ps to the AC maximum specification.

Dynamic Switching Characteristics (Ta = 25°C, input $t_r = t_f = 2.0$ ns, $C_L = 30$ pF)

Characteristics	Symbol	Test Condition		TYP.	Unit
Characteristics	Gymbol	rest Condition	V _{CC} (V)		Offic
Quiet Output Maximum Dynamic		$V_{IN} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 1.8	0.25	
V _{OL}	V_{OLP}	$V_{IN} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 2.5	0.6	ns
VOL		$V_{IN} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 3.3	0.8	
Quiet Output Minimum Dynamic		$V_{IN} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 1.8	-0.25	
V _{OI}	V_{OLV}	$V_{IN} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 2.5	-0.6	ns
V OL		$V_{IN} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 3.3	-0.8	
Quiet Output Minimum Dynamic		$V_{IN} = 1.8 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 1.8	1.5	
Voh	V_{OLP}	$V_{IN} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 2.5	1.9	ns
VОН		$V_{IN} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ (Note	11) 3.3	2.2	

Note 11: Characteristics guaranteed by design.

Capacitive Characteristics (Ta = 25°C)

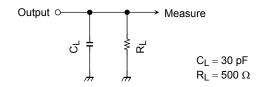
Characteristics	Symbol		Test Condition		V _{CC} (V)	TYP.	Unit
Input Capacitance	C _{IN}		_		1.8, 2.5, 3.3	4	pF
Power Dissipation Capacitance	C _{PD}	f _{IN} = 10 MHz		(Note 12)	1.8, 2.5, 3.3	12	pF

Note 12: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

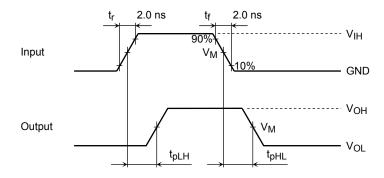
 $I_{CC\ (opr.)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/2$

Figure 1 Test Circuit



AC Waveforms

Figure 2 t_{pLH}, t_{pHL}



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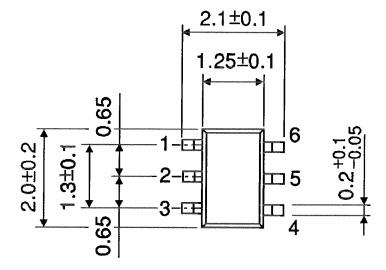
Symbol	Vcc					
Symbol	$3.3\pm0.3~\textrm{V}$	$2.5\pm0.2~\textrm{V}$	1.8 V			
V_{IH}	2.7 V	V _{CC}	V _{CC}			
V _M	1.5 V	V _{CC} /2	V _{CC} /2			

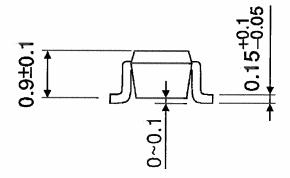
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Package Dimensions

SSOP6-P-0.65A

Unit: mm





Weight: 0.0068 g (typ.)

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20070701-EN GENERAL

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